

Test Report

No. : CE/2010/74382 Date : 2010/07/27 Page : 1 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description : SURFACE MOUNTED ELECTRONIC DEVICE
Style/Item No. : SOD-923
Sample Receiving Date : 2010/7/22
Testing Period : 2010/7/22 TO 2010/07/27

=====
Test Result(s) : Please refer to next page(s).

Conclusion : Base upon the performed tests by submitted samples, the test results of PAHs comply with the PAHs requirement according to (Category 1) of ZEK 01.2-08 of German ZLS and its amendments.



Chenyu Kung / Operation Manager
Signed for and on behalf of
SGS TAIWAN LTD.
Chemical Laboratory – Taipei

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company.
除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。
This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

No. : CE/2010/74382 Date : 2010/07/27 Page : 2 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



Test Result(s)

PART NAME NO.1 : SURFACE MOUNTED ELECTRONIC DEVICE

Test Item (s):	Unit	Method	MDL	Result
				NO.1
Cadmium (Cd)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Lead (Pb)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Mercury (Hg)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES.	2	n.d.
Hexavalent Chromium Cr(VI) by alkaline extraction	mg/kg	With reference to IEC 62321: 2008 and performed by UV-VIS.	2	n.d.
Antimony (Sb)	mg/kg	With reference to US EPA Method 3050B for Antimony Content. Analysis was performed by ICP-AES.	2	670
Perfluorooctane sulfonates (PFOS) PFOS – Acid PFOS – Metal Salt PFOS – Amide	mg/kg	With reference to US EPA 3540C: 1996 method for PFOS Content. Analysis was performed by LC/MS.	10	n.d.
PFOA (CAS No.: 000335-67-1)	mg/kg	With reference to US EPA 3540C: 1996 method for PFOA Content. Analysis was performed by LC/MS.	10	n.d.
Halogen				
Halogen-Fluorine (F) (CAS No.: 014762-94-8)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.
Halogen-Chlorine (Cl) (CAS No.: 022537-15-1)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.
Halogen-Bromine (Br) (CAS No.: 010097-32-2)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	414
Halogen-Iodine (I) (CAS No.: 014362-44-8)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company.
除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

No. : CE/2010/74382 Date : 2010/07/27 Page : 3 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



Test Item (s):	Unit	Method	MDL	Result
				NO.1
Polynuclear Aromatic Hydrocarbons (PAHs)				
Acenaphthene (CAS No.: 000083-32-9)	mg/kg	With reference to ZLS standard ZEK 01.2-08 method. Analysis was performed by GC/MS.	0.2	n.d.
Acenaphthylene (CAS No.: 000208-96-8)			0.2	n.d.
Anthracene (CAS No.: 000120-12-7)			0.2	n.d.
Benzo[a]anthracene (CAS No.: 000056-55-3)			0.2	n.d.
Benzo[a]pyrene (CAS No.: 000050-32-8)			0.2	n.d.
Benzo[b]fluoranthene (CAS No.: 000205-99-2)			0.2	n.d.
Benzo[g,h,i]perylene (CAS No.: 000191-24-2)			0.2	n.d.
Benzo[k]fluoranthene (CAS No.: 000207-08-9)			0.2	n.d.
Chrysene (CAS No.: 000218-01-9)			0.2	n.d.
Dibenzo[a,h]anthracene (CAS No.: 000053-70-3)			0.2	n.d.
Fluoranthene (CAS No.: 000206-44-0)			0.2	n.d.
Fluorene (CAS No.: 000086-73-7)			0.2	n.d.
Indeno[1,2,3-c,d] pyrene (CAS No.: 000193-39-5)			0.2	n.d.
Naphthalene (CAS No.: 000091-20-3)			0.2	n.d.
Phenanthrene (CAS No.: 000085-01-8)			0.2	n.d.
Pyrene (CAS No.: 000129-00-0)			0.2	n.d.
Sum of 16 PAHs			-	n.d.

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company.
除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

No. : CE/2010/74382 Date : 2010/07/27 Page : 4 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



Test Item (s):	Unit	Method	MDL	Result
				NO.1
Sum of PBBs	mg/kg	With reference to IEC 62321: 2008 and performed by GC/MS.	-	n.d.
Monobromobiphenyl			5	n.d.
Dibromobiphenyl			5	n.d.
Tribromobiphenyl			5	n.d.
Tetrabromobiphenyl			5	n.d.
Pentabromobiphenyl			5	n.d.
Hexabromobiphenyl			5	n.d.
Heptabromobiphenyl			5	n.d.
Octabromobiphenyl			5	n.d.
Nonabromobiphenyl			5	n.d.
Decabromobiphenyl			5	n.d.
Sum of PBDEs			-	n.d.
Monobromodiphenyl ether			5	n.d.
Dibromodiphenyl ether			5	n.d.
Tribromodiphenyl ether			5	n.d.
Tetrabromodiphenyl ether			5	n.d.
Pentabromodiphenyl ether			5	n.d.
Hexabromodiphenyl ether			5	n.d.
Heptabromodiphenyl ether			5	n.d.
Octabromodiphenyl ether			5	n.d.
Nonabromodiphenyl ether			5	n.d.
Decabromodiphenyl ether			5	n.d.

Note :

1. mg/kg = ppm ; 0.1wt% = 1000ppm
2. n.d. = Not Detected
3. MDL = Method Detection Limit
4. " - " = Not Regulated

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company.
除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

No. : CE/2010/74382 Date : 2010/07/27 Page : 5 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



Reference information for PAHs:

Requirement of ZEK 01.2-08 : Restraining maximum values for products

Parameter	Category 1	Category 2	Category 3
	Materials in contact with foodstuff or materials which are meant to put in the mouth as well as toys for children <36 months.	Materials with foreseeable skin contact >30 s (prolonged skin contact) and toys not covered by category 1.	Materials with foreseeable skin contact <30 s (short time skin contact) or without skin contact.
Benzo[a]pyrene (mg/kg)	<MDL (<0.2)**	1	20
Sum of 16 EPA-PAH (mg/kg)*	<MDL (<0.2)**	10	200

Remark :

* = Only PAH substances >0.2 mg/kg are taken into account while calculating the sum of PAHs

** = In case that the maximum values exceed the limits of category 1, but are within the limits of category 2, one may confirm the suitability of the tested material for contact with foodstuff or oral mucosa by additional specific migration tests of PAH components based on DIN EN 1186ff and §64 LFGB 80.30-1. The conclusion of the migration test results must be made based on food law criteria.

PFOS Reference Information : Directive 2006/122/EC

(1) May not be placed on the market or used as a substance or constituent of preparations in a concentration equal to or higher than 0.005 % by mass.

(2) May not be placed on the market in semi-finished products or articles, or parts thereof, if the concentration of PFOS is equal to or higher than 0.1 % by mass calculated with reference to the mass of structurally or microstructurally distinct parts that contain PFOS or, for textiles or other coated materials, if the amount of PFOS is equal to or higher than 1µg/m² of the coated material.

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company. 除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

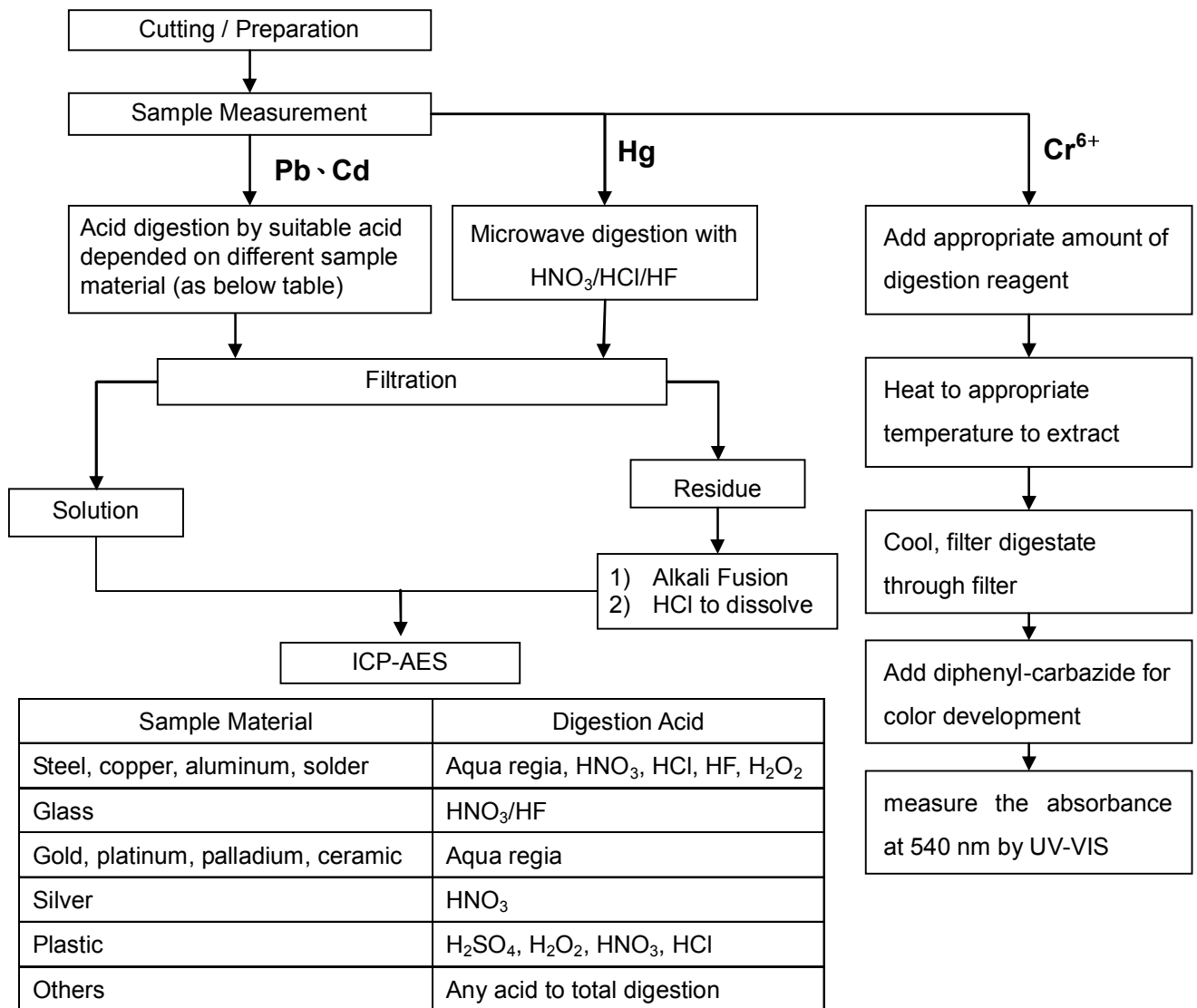
Test Report

No. : CE/2010/74382 Date : 2010/07/27 Page : 6 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



- 1) These samples were dissolved totally by pre-conditioning method according to below flow chart.
(Cr⁶⁺ test method excluded)
- 2) Name of the person who made measurement: Climbgreat Yang
- 3) Name of the person in charge of measurement: Troy Chang



Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company.
除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

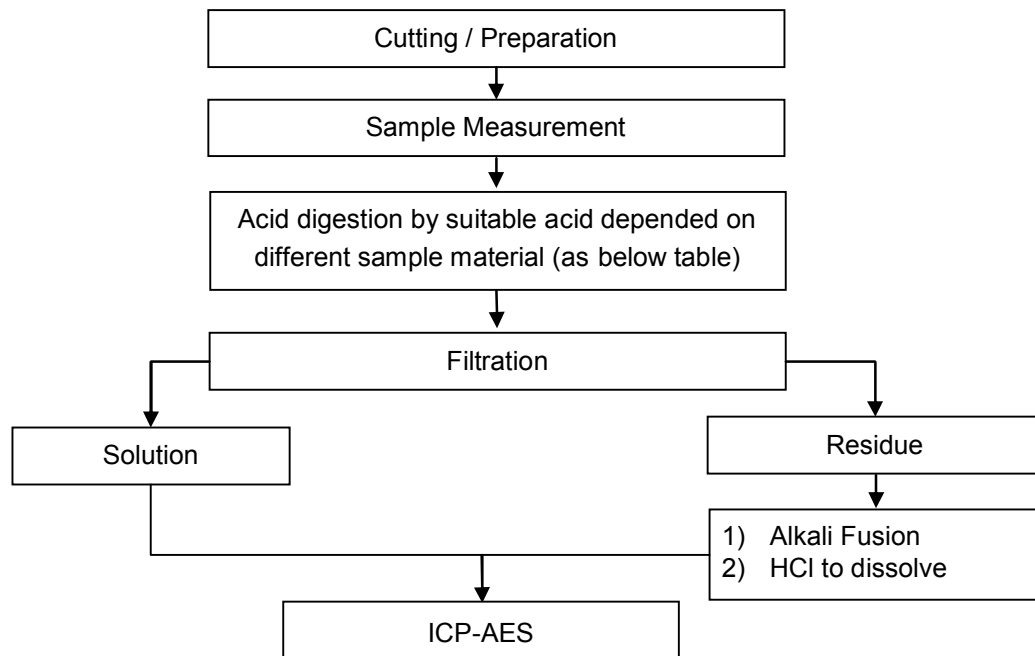
No. : CE/2010/74382 Date : 2010/07/27 Page : 7 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



- 1) These samples were dissolved totally by pre-conditioning method according to below flow chart.
- 2) Name of the person who made measurement: Climbgreat Yang
- 3) Name of the person in charge of measurement: Troy Chang

Flow Chart of digestion for the elements analysis performed by ICP-AES



Steel, copper, aluminum, solder	Aqua regia, HNO ₃ , HCl, HF, H ₂ O ₂
Glass	HNO ₃ /HF
Gold, platinum, palladium, ceramic	Aqua regia
Silver	HNO ₃
Plastic	H ₂ SO ₄ , H ₂ O ₂ , HNO ₃ , HCl
Others	Any acid to total digestion

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company.
除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

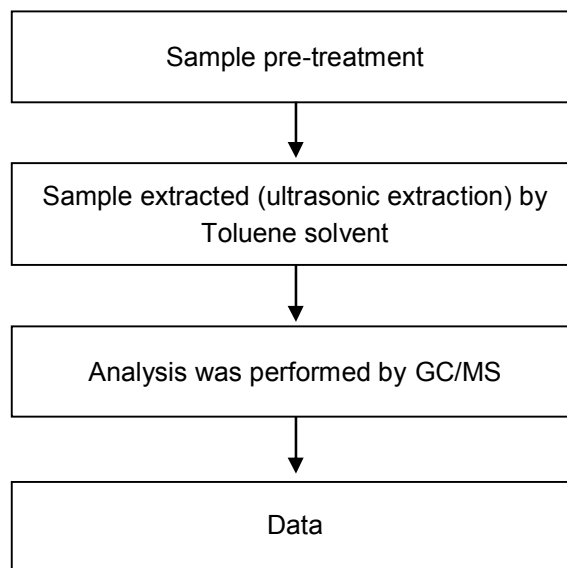
No. : CE/2010/74382 Date : 2010/07/27 Page : 8 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



PAHs (Polynuclear Aromatic Hydrocarbons) analytical flow chart

- 1) Name of the person who made measurement: Andy Shu
- 2) Name of the person in charge of measurement: Shinjyh Chen



Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company. 除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

No. : CE/2010/74382 Date : 2010/07/27 Page : 9 of 12

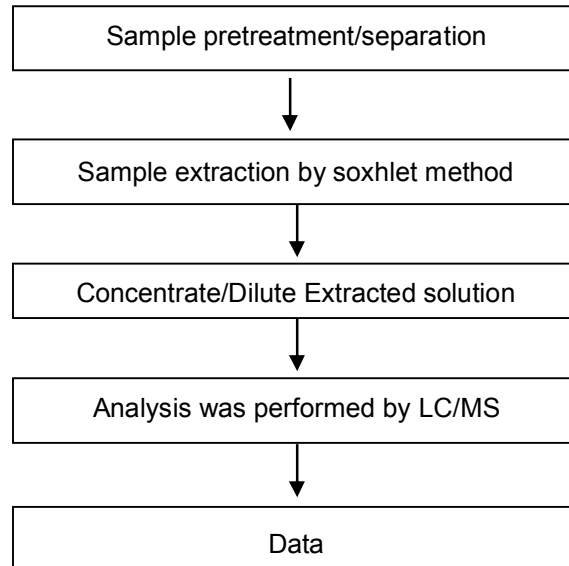
LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



Analytical flow chart of Soxhlet extraction (LC/MS) procedure

- 1) Name of the person who made measurement: Lydia Fu
- 2) Name of the person in charge of measurement: Shinjyh Chen

■ Test Items: PFOS/PFOA、Benzotriazole



Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company. 除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

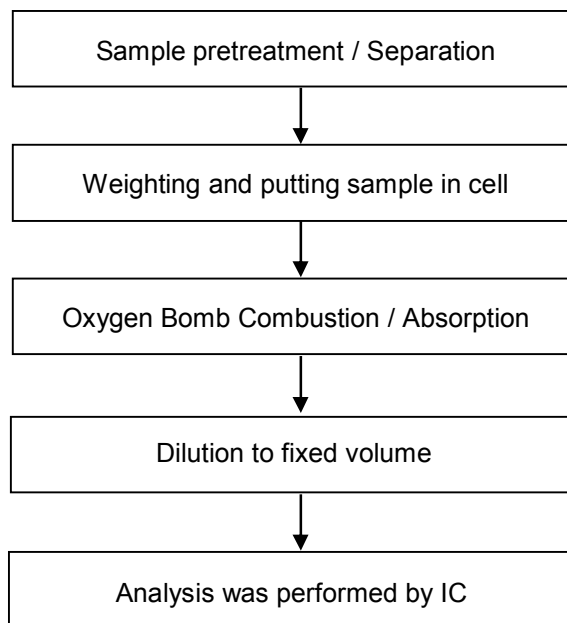
No. : CE/2010/74382 Date : 2010/07/27 Page : 10 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



Analytical flow chart of halogen content

- 1) Name of the person who made measurement: Rita Chen
- 2) Name of the person in charge of measurement: Troy Chang



Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company. 除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

No. : CE/2010/74382 Date : 2010/07/27 Page : 11 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN

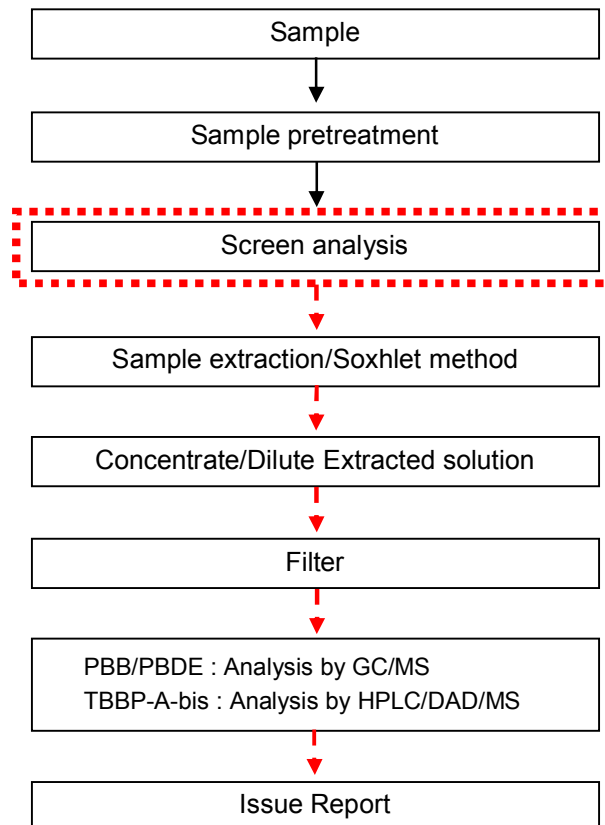


Analytical flow chart

- 1) Name of the person who made measurement: Roman Wong
- 2) Name of the person in charge of measurement: Troy Chang

■ Test Items: PBB/PBDE, TBBP-A-bis

First testing process —> Optional screen process Confirmation process ->



Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company. 除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.

Test Report

No. : CE/2010/74382 Date : 2010/07/27 Page : 12 of 12

LITE-ON SEMICONDUCTOR CORP.
28-1, WU SHIN STREET, TA WU LUNG, KEELUNG, TAIWAN



** End of Report **

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested. This test report cannot be reproduced, except in full, without prior written permission of the Company. 除非另有說明，此報告結果僅對測試之樣品負責。本報告未經本公司書面許可，不可部分複製。

This Test Report is issued by the Company under its General Conditions of Service printed overleaf or available on request and accessible at http://www.sgs.com/terms_and_conditions.htm. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this Test Report is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law.